

NATIONAL RADIO ASTRONOMY OBSERVATORY
SOCORRO, NEW MEXICO
VERY LARGE ARRAY PROGRAM

VLA ELECTRONICS MEMORANDUM NO. 168

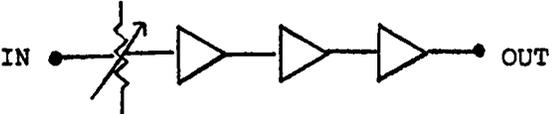
PHASE STABILITY OF SOME COMPONENTS
AND SUB-SYSTEMS IN VLA ELECTRONICS

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1.0 INTRODUCTION

Phase stability of many components and sub-systems was measured during 1976-1977 while trying to understand phase stability of the VLA system. In most cases stress was to determine phase-stability with temperature variation ($\Delta\phi/\Delta T$) around room temperature. For many components phase variations with other parameters like power level, gain, etc. were also determined. The results are given in this report.

COMPONENT/SIGNAL DESCRIPTION	PHASE VARIATION WITH	CONDITION OF MEASUREMENT AND/OR TEST SET-UP	RESULTS - NOTES
<p>1. <u>Band-Pass Filters</u></p> <p>a) 1/2" tubular coaxial BPF by K&L Microwave, Inc. Filters in frequency range of 100 to 2000 MHz</p> <p>b) IF band-pass filters in 1 to 2GHz range for Front End IF filters (F7) and 1F off-set (F8) modules. Designed by RLC Electronics.</p> <p>c) 10.1 MHz crystal BPF in Fringe Generator (L7) module having 3 dB bandwidth = 30 kHz.</p>	<p>Temperature</p> <p>Temperature</p> <p>Temperature</p>	<p>Figure 1</p> <p>Figure 1</p> <p>Figure 1</p>	<p>$k = 30 \text{ to } 70 \times 10^{-6}$ (see Note 1)</p> <p>A 4-section 1325/60 MHz BPF has $\Delta\phi/\Delta T \sim 0.05^\circ/\text{C}$. This gives $k \sim 6 \times 10^{-6}$ (see Note 1)</p> <p>$\Delta\phi/\Delta T$ at 10.1 MHz = $0.2^\circ/\text{C}$</p>
<p>2. <u>1 to 2 GHz Amplifiers</u></p> <p>a) Avantek ASD8199M Gain ~ 27 dB, P_{out} at 1 dB Compression = +7dBm</p> <p>b) Variable gain amplifier consisting of following stages:</p>  <p>Type: G1 UTO- UTO- A37 2002 2003</p> <p>Mfr: WJ AVANTEK WJ</p>	<p>Temperature</p> <p>Power Supply Voltage</p> <p>Output Power</p> <p>Temperature at different P_{out}, and gain values for input at both 1200 and 1800 MHz simultaneously</p>	<p>Figure 2A, @ 1800 MHz and $P_{out} = +10$ dBm</p> <p>Variation by ± 500 mV @ + 15 V and $P_{out} = 0$ to 10 dBm at 1200 MHz.</p> <p>At $P_{out} = +7$ dBm for both 1200 and 1800 MHz</p> <p>At $P_{out} = 0$ dBm for both 1200 and 1800 MHz</p> <p>Test set up Figure 2B</p>	<p>$\Delta\phi/\Delta T \sim 0.2^\circ/\text{C}$</p> <p>$\Delta\phi \leq 0.3^\circ$ for ± 500 mV</p> <p>$\Delta\phi/\Delta P_{in} \leq 0.15^\circ/\text{dB}$</p> <p>$\Delta\phi/\Delta P_{in} \leq 0.05^\circ/\text{dB}$</p> <p>For results see Figure 2C</p>

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<p>2. b) (Cont'd)</p> <p>Maximum Gain - 25 dB</p> <p>P_{out} @ 1 dB Compression = +15 dBm at 1200 and 1800 MHz</p> <p>c) LOCUS Amplifier RF668 used in Transmit side of MODEM (T1) modules.</p> <p>Gain = 28 ± 1 dB</p> <p>P_{out} at 1 dB compression = +17 dBm (Min)</p>	Temperature	Figure 2B; P_{out} (Total) = +17 dBm (+14 dB at each 1200 and 1800 MHz)	$\Delta\phi/\Delta T \sim 0.35^\circ/\text{C}$ @ 1800 MHz																																
3. <u>Balanced Mixers</u>																																			
<p>a) Watkins-Johnson Mixer M1A used as phase detector at 50 MHz</p>	Temperature at different L.O. Power	Figure 3A, RF port power - -3 dBm	$\Delta\phi/\Delta T$ (@ $P_{LO}=+17\text{dBm}$) = $0.13^\circ/\text{C}$ (@ $P_{LO}=+10\text{dBm}$) = $0.2^\circ/\text{C}$ (@ $P_{LO}=0\text{dBm}$) = $0.8^\circ/\text{C}$																																
b) Watkins-Johnson Mixer M1J used as Modulator	Temperature, L.O. Power, Modulation	Figure 4A	Figure 4B																																
4. PIN Diode Attenuator, Vectronics Microwave Corporation type DA 0125-40	Attenuation	Figure 5	<table border="0"> <tr> <td>ATT.(dB)</td> <td>0</td> <td>5</td> <td>10</td> <td>15</td> <td>20</td> <td>25</td> <td>30</td> </tr> <tr> <td>PHASE($^\circ$)</td> <td>0</td> <td>5</td> <td>7</td> <td>8</td> <td>7.5</td> <td>5.5</td> <td>4</td> </tr> <tr> <td>ATT</td> <td>35</td> <td>40</td> <td></td> <td></td> <td></td> <td></td> <td></td> </tr> <tr> <td>PHASE</td> <td>2</td> <td>0</td> <td></td> <td></td> <td></td> <td></td> <td></td> </tr> </table>	ATT.(dB)	0	5	10	15	20	25	30	PHASE($^\circ$)	0	5	7	8	7.5	5.5	4	ATT	35	40						PHASE	2	0					
ATT.(dB)	0	5	10	15	20	25	30																												
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5. 50 MHz COMB GENERATOR using step recovery diode HP 5082-0112	Temperature	Figure 6, @ 1800 MHz	$\Delta\phi/\Delta T=0.6^\circ/\text{C}$; $\Delta\phi/\Delta P_{in} \sim 2^\circ/\text{dB}$ Phase stability using SRD type HP 5082-0820 is similar. For 50 MHz Harmonic Generator (L2C) module comb generator employing HP 0820 diode is used																																

COMPONENT/SIGNAL DESCRIPTION	PHASE VARIATION WITH	CONDITION OF MEASUREMENT AND/OR TEST SET-UP	RESULTS - NOTES
6. <u>L1: 5 to 50 MHz VCXO</u> a) 5 MHz b) 50 MHz	Temperature	Figure 7	$\Delta\phi_5/\Delta T \leq 0.1^\circ/\text{C}$ $\Delta\phi_{50}/\Delta T \approx 2^\circ/\text{C}$ The phase variation of the phase shifter in 5 MHz (5 ϕ) is $\leq 0.05^\circ/\text{C}$
7. <u>L2A: 50 to 600 MHz Multiplier</u> a) 100 MHz b) 600 MHz	Temperature	Similar to Figure 8	$\Delta\phi_{100}/\Delta T \sim 0.38^\circ/\text{C}$ $\Delta\phi_{600}/\Delta T \sim 1.7^\circ/\text{C}$
8. <u>L2C: 50 MHz Harmonic Generator</u> a) 600 MHz line in 50 MHz Comb b) 1200 MHz Output c) 1800 MHz Output	Temperature	Figure 8	$\Delta\phi_{600}/\Delta T = 0.2^\circ/\text{C}$ $\Delta\phi_{1200}/\Delta T = 0.3^\circ/\text{C}$ $\Delta\phi_{1800}/\Delta T = 0.5^\circ/\text{C}$
9. <u>L2C (50 MHz Harmonic Generator) and L3C (Antenna L.O. Transmitter) Together</u> a) 600 MHz @ L3J10 b) 1200 MHz @ L3J8 c) 1800 MHz @ L3J8	Temperature	Figure 9	$\Delta\phi_{600}/\Delta T \sim 0.2^\circ/\text{C}$ $\Delta\phi_{1200}/\Delta T \sim 0.4^\circ/\text{C}$ $\Delta\phi_{1800}/\Delta T \sim 0.6^\circ/\text{C}$
10. L2C, L3C and L6 (2-4 GHz Synthesizer) a) 600 MHz from 50 MHz comb @ L2J12 b) 1200 MHz @ L3J8 c) 2990 MHz @ L6J12	Temperature	Figure 10	$\Delta\phi_{600}/\Delta T \sim 0.2^\circ/\text{C}$ $\Delta\phi_{1200}/\Delta T \sim 0.35^\circ/\text{C}$ $\Delta\phi_{2990}/\Delta T \sim 1^\circ/\text{C}$

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11. <u>L7: Fringe Generator</u> 10.1 MHz	Temperature	Figure 11, fringe rate set to zero.	$\Delta\phi_{10.1}/\Delta T \sim 0.65^\circ/\text{C}$
12. <u>T2: IF Combiner</u> XMIT 1200 MHz XMIT 1800 MHz RCV 1200 MHz RCV 1800 MHz	Temperature and Power Level	Figure 12	XMIT @ 1200 $\Delta\phi/\Delta T = .05^\circ/\text{C}$ XMIT @ 1800 $\Delta\phi/\Delta T = 0.1^\circ/\text{C}$ RCV @ 1200 $\Delta\phi/\Delta T = 0.1^\circ/\text{C}$ RCV @ 1800 $\Delta\phi/\Delta T = 0.15^\circ/\text{C}$
13. <u>F4: Frequency Converter</u> <u>(Proposed Design)</u>	Temperature, Power Level	Figure 13A, B	$\Delta\phi/\Delta T$ @ 1010 MHz = $0.1^\circ/\text{C}$ $\Delta\phi/\Delta P_{in} \leq 0.2^\circ/\text{dB}$ for fixed output around nominal value of VCA attenuation
14. <u>Vertex Room Front End Electronics at L-Band (Antenna 3)</u> a) From upconverter up to F4 output b) From upconverter up to T2 XMIT IF monitor on front panel	Temperature A-Rack Power Supply	Figure 14 Figure 14 Each power supply voltage varied separately by 100 mV	$\frac{\Delta\phi}{\Delta T}$ (up to F4) ~ 3 to $4^\circ/\text{C}$ $\frac{\Delta\phi}{\Delta T}$ (up to T2) ~ $3^\circ/\text{C}$ 100 mV @ +15 V gives $\Delta\phi \leq 1^\circ$ 100 mV @ -15 V gives $\Delta\phi \leq 1^\circ$ 100 mV @ +5 V gives $\Delta\phi \leq 1^\circ$

Note 1 - Phase variation at center frequency of pass-band is expressed: $\frac{\Delta\phi}{\Delta T}$ (in degrees) = $m \times 90^\circ \times \frac{f}{BW} \cdot k$

where, m = number of sections
 f_o = center frequency
 BW = 3 dB bandwidth
 k = A constant, whose value is determined

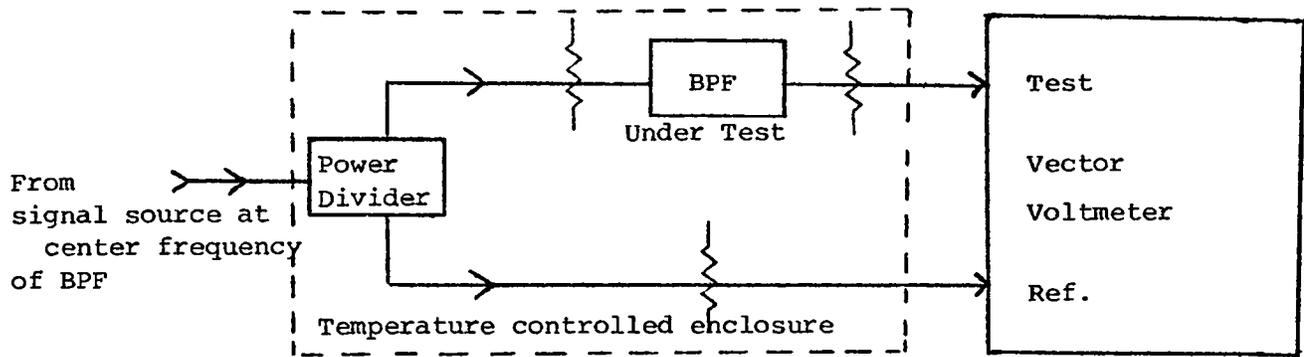


FIGURE 1: SET UP FOR MEASURING BPF PHASE VARIATIONS WITH TEMPERATURE

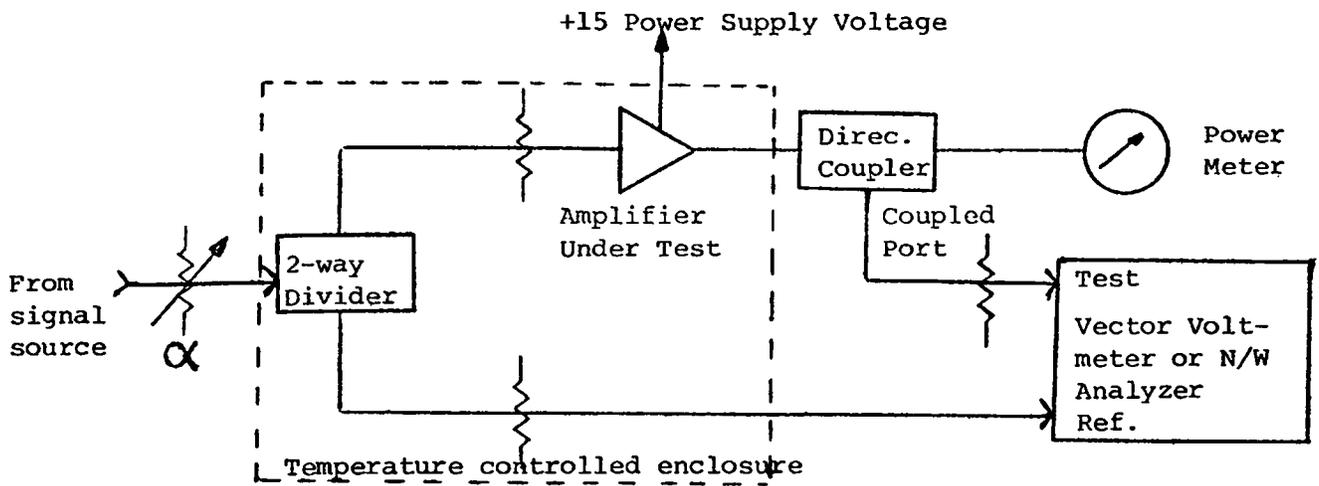


FIGURE 2A: SET UP FOR MEASURING 1-2 GHz AMPLIFIER PHASE STABILITY

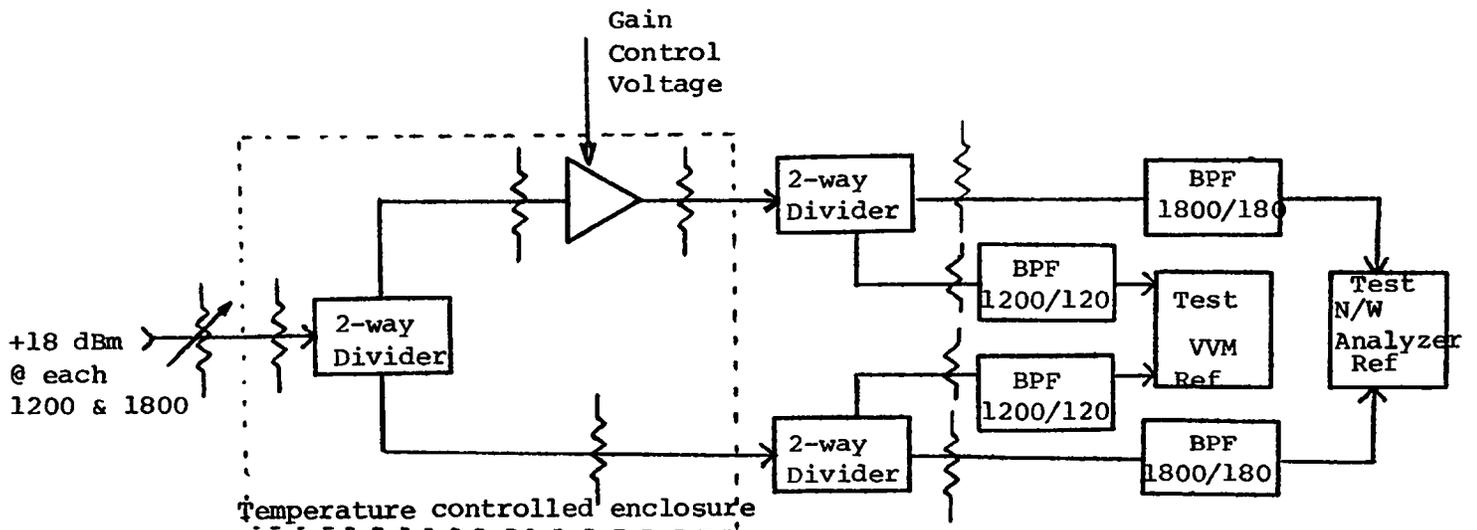


FIGURE 2B: SET UP TO MEASURE PHASE STABILITY OF VARIABLE GAIN 1-2 GHz AMPLIFIER

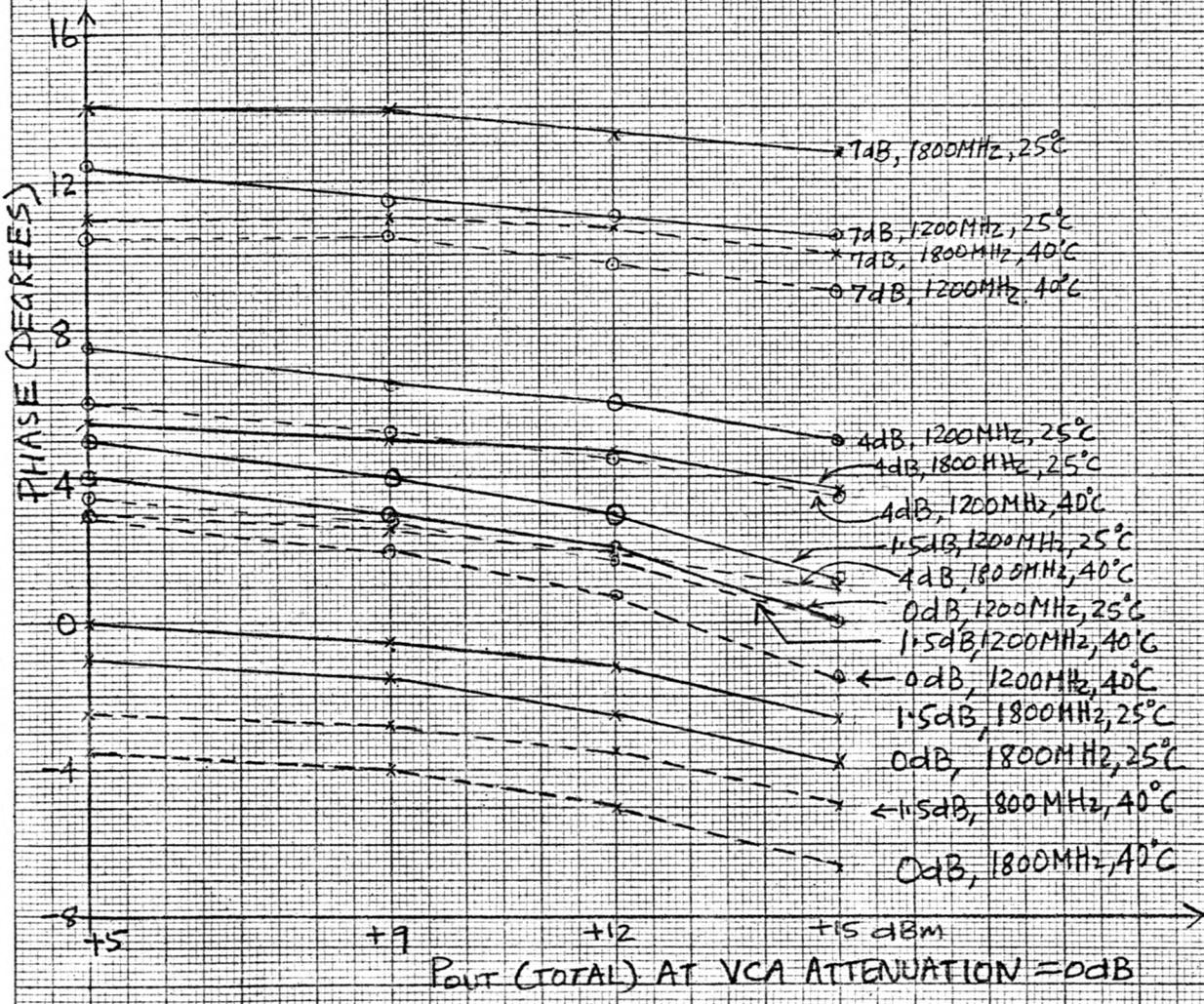


FIGURE 2C: PHASE VARIATIONS WITH P_{out} , GAIN, TEMPERATURE AT 1200 AND 1800 MHz (see Figure 2B for set up)

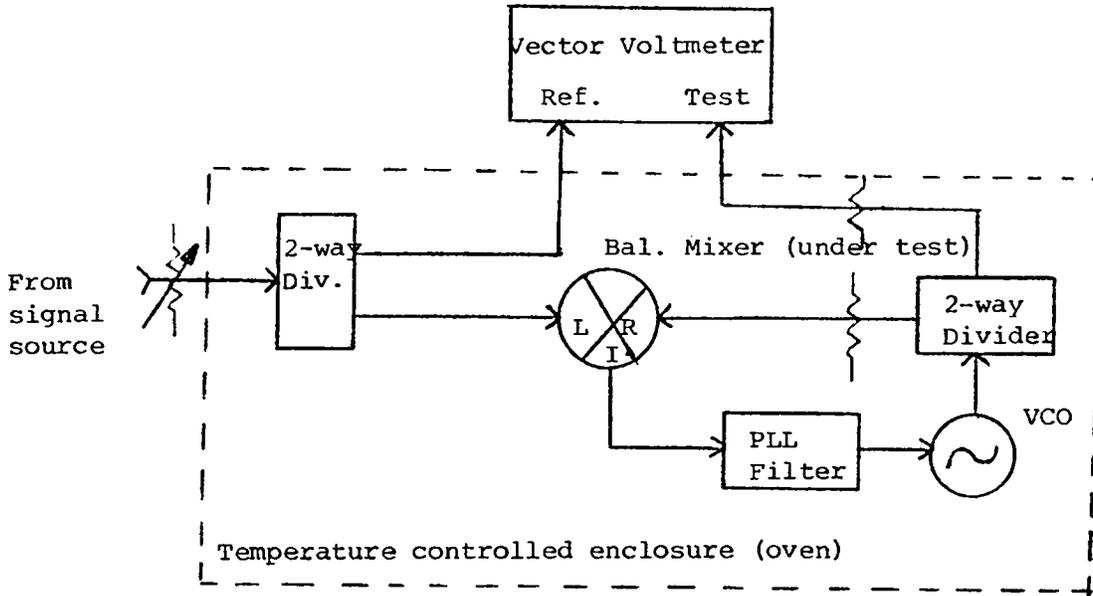
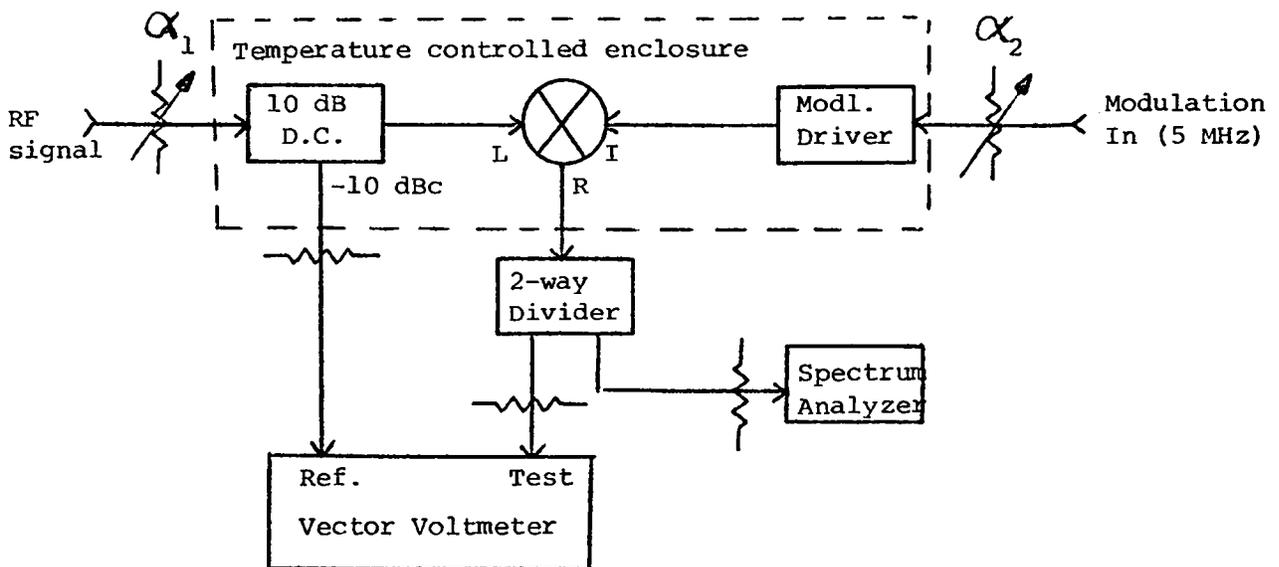


FIGURE 3: SET UP FOR MEASURING PHASE STABILITY OF BALANCED MIXER MIA USED AS PHASE DETECTOR AT 50 MHz



- 1) Modulation is adjusted to give ± 5 MHz sidebands to carrier ratio = -10 dBc
- 2) Modulator driver bias adjusted to give modulator carrier output = -18 dBm

FIGURE 4A: SET UP FOR MEASURING PHASE STABILITY OF A MODULATOR

$P_{L.O.}$	dBm	+2	+5	+9	+13
$\Delta\phi/\Delta P_{in(L.O.)}$	($^{\circ}/dB$)	2°	3°	1.5°	1°
$\Delta\phi/\Delta P_{mod}$	(*)	$<0.1^{\circ}$	$<0.1^{\circ}$	$<0.1^{\circ}$	$<0.1^{\circ}$
$\Delta\phi/\Delta T$	($^{\circ}/^{\circ}C$)	0.23	0.22	0.20	0.20

*when 5 MHz modulation/carrier ratio reduced from
-10 to -20 dBc

FIGURE 4B: RESULTS OF MODULATOR PHASE STABILITY

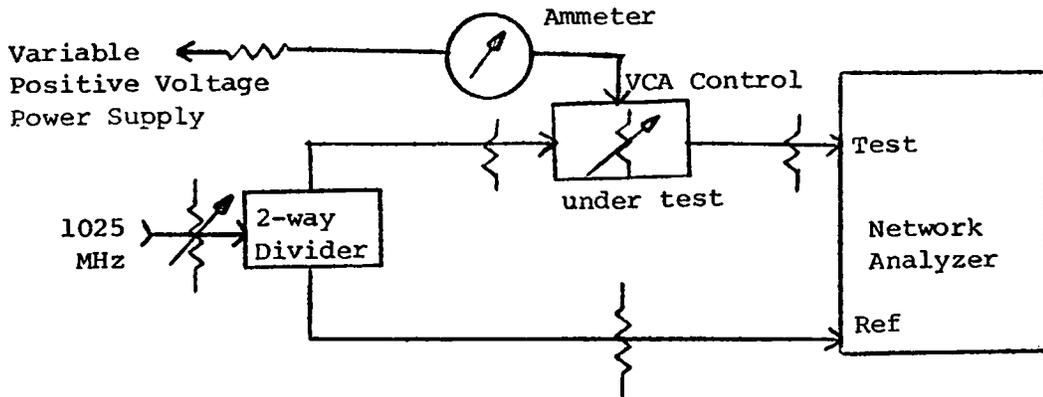


FIGURE 5: SET UP FOR MEASURING PHASE VARIATION WITH ATTENUATION FOR PIN DIODE ATTENUATOR

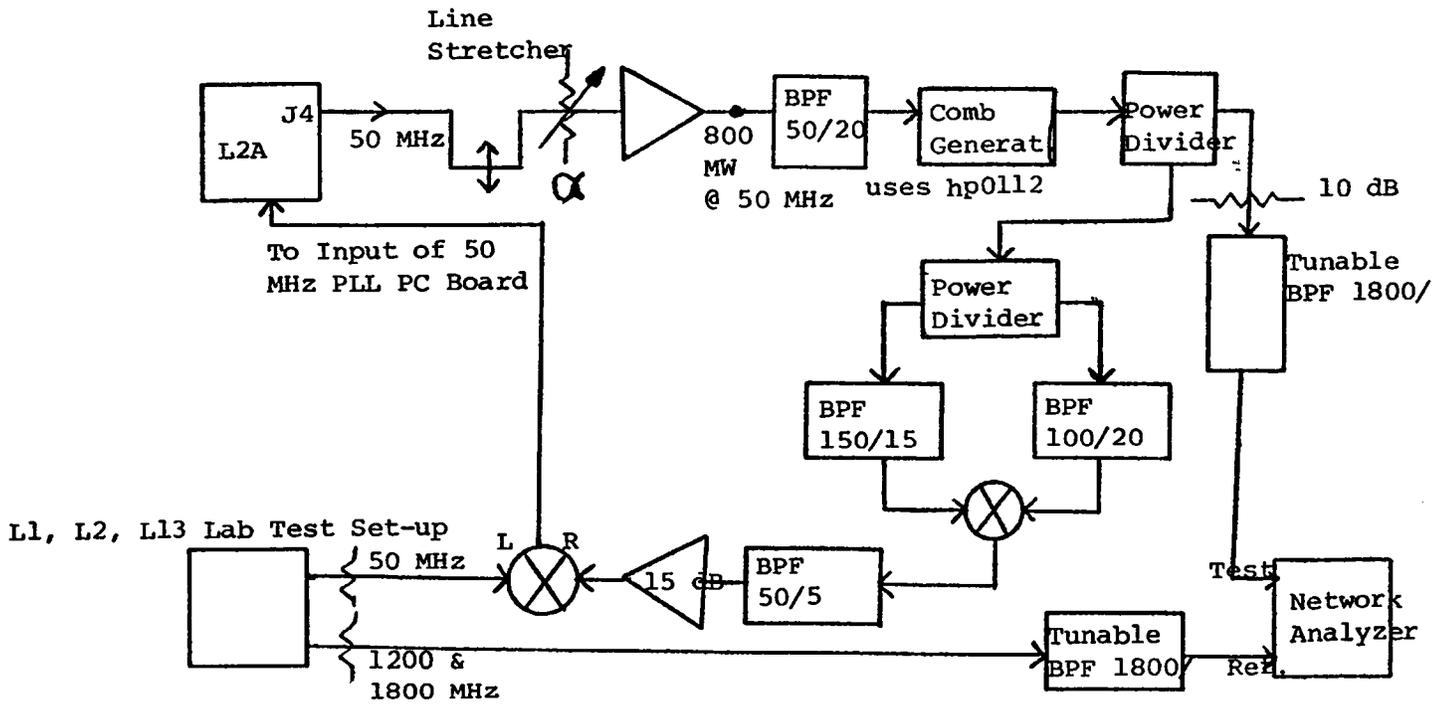


FIGURE 6: SET UP FOR MEASURING PHASE STABILITY OF 50 MHz COMB-GENERATOR

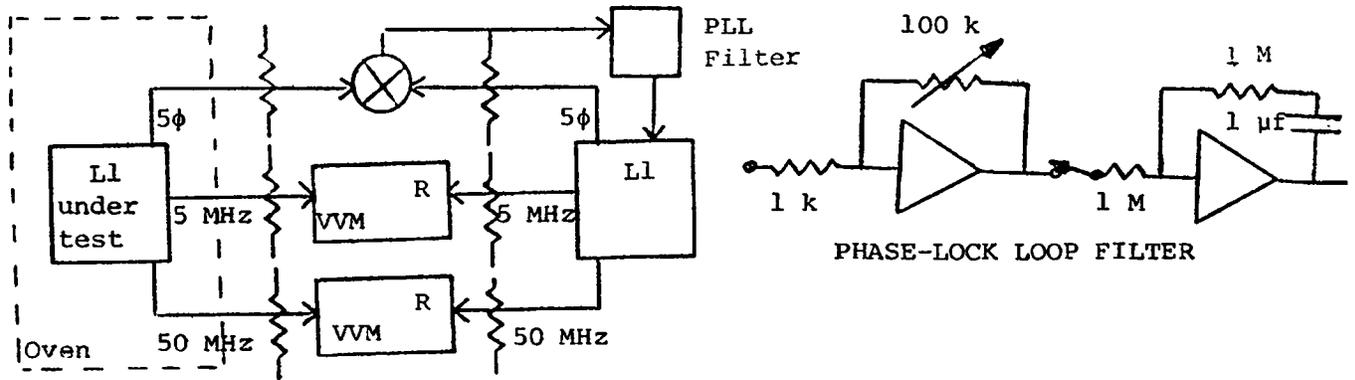


FIGURE 7: SET UP FOR MEASURING PHASE VARIATION WITH TEMPERATURE OF L1 MODULE SIGNALS

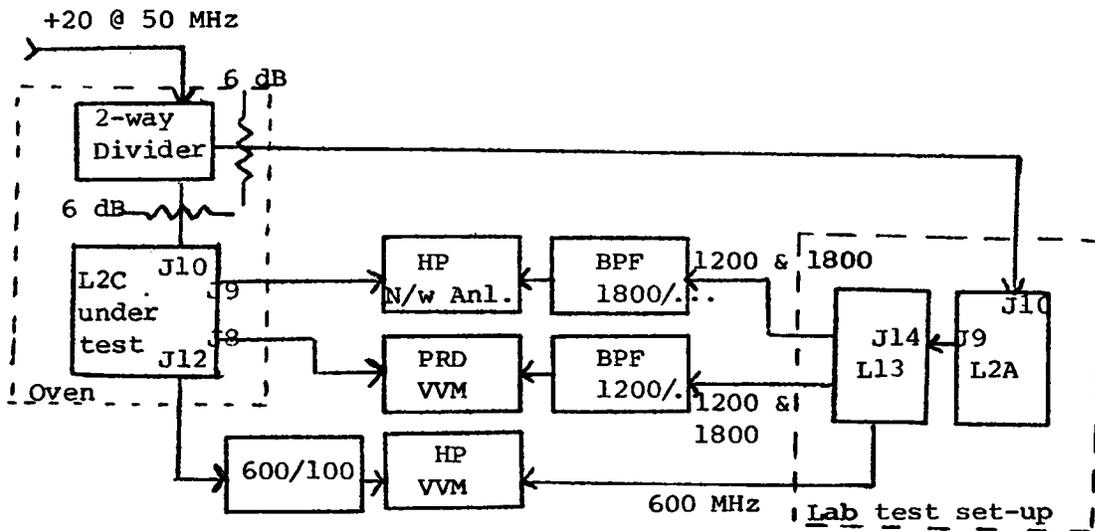


FIGURE 8: SET UP FOR MEASURING PHASE VARIATION WITH TEMPERATURE OF L2C MODULE

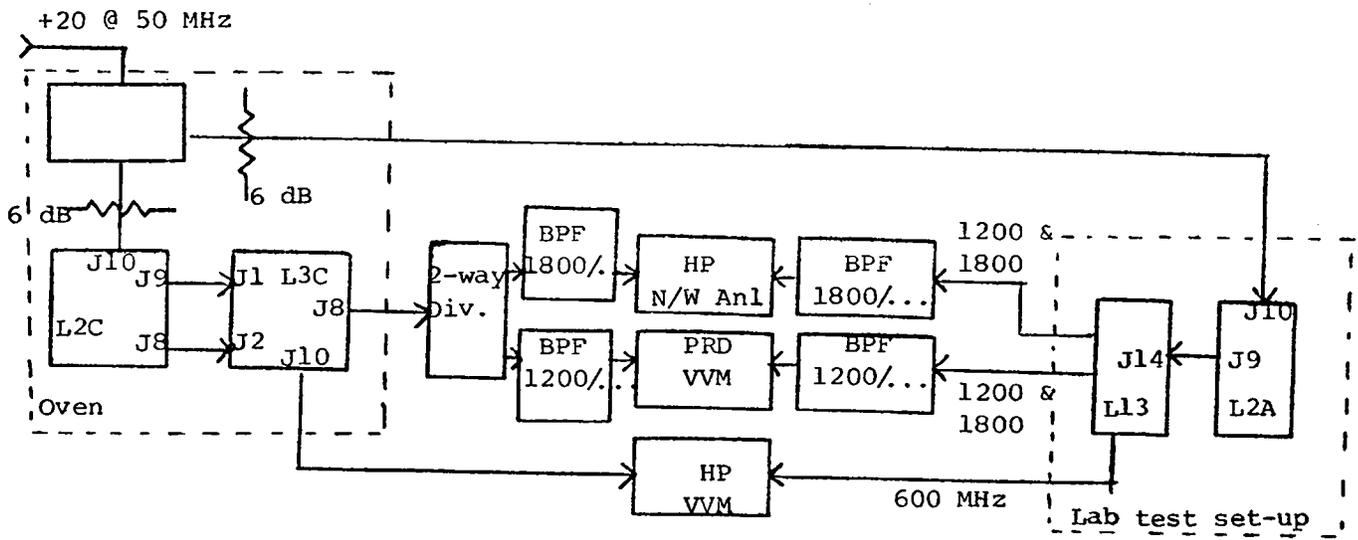
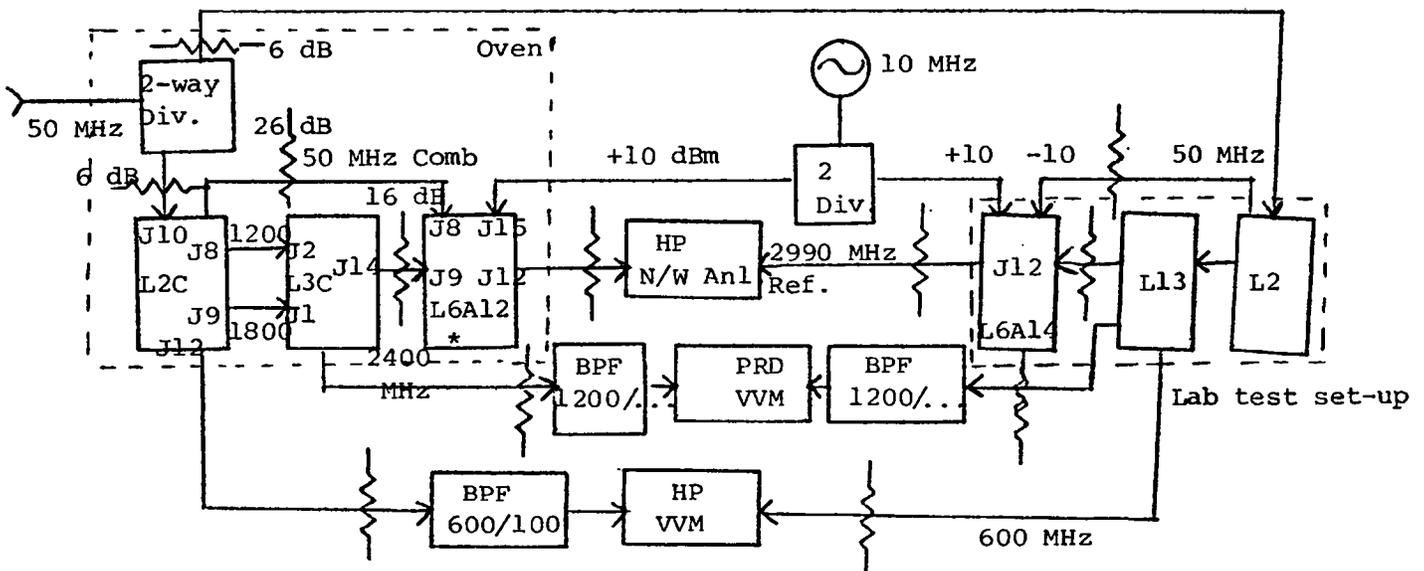


FIGURE 9: SET UP FOR MEASURING PHASE VARIATIONS WITH TEMPERATURE OF L2C AND L3C TOGETHER



*50 MHz Comb Generator inside L6A12 bypassed, temperature probe on L6A12 center plate.

FIGURE 10: SET UP TO MEASURE PHASE VARIATION WITH TEMPERATURE FOR MODULES L2C, L3C and L6

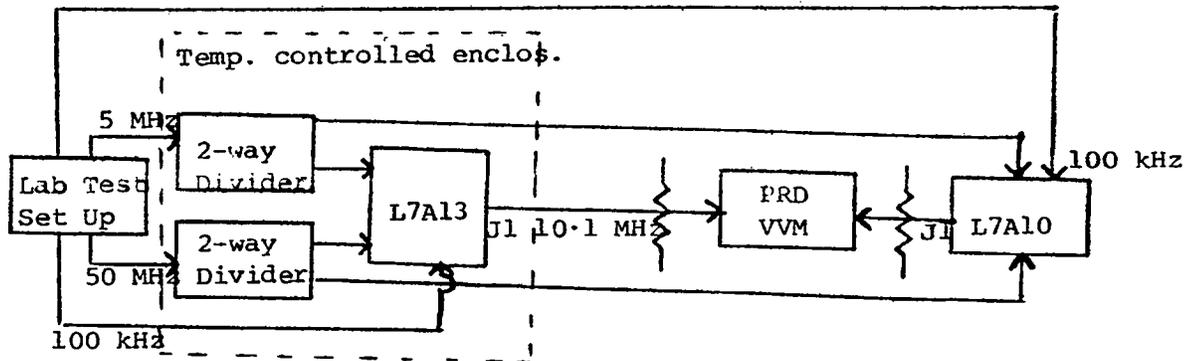


FIGURE 11: SET UP TO MEASURE PHASE VARIATION WITH TEMPERATURE FOR L7 MODULE

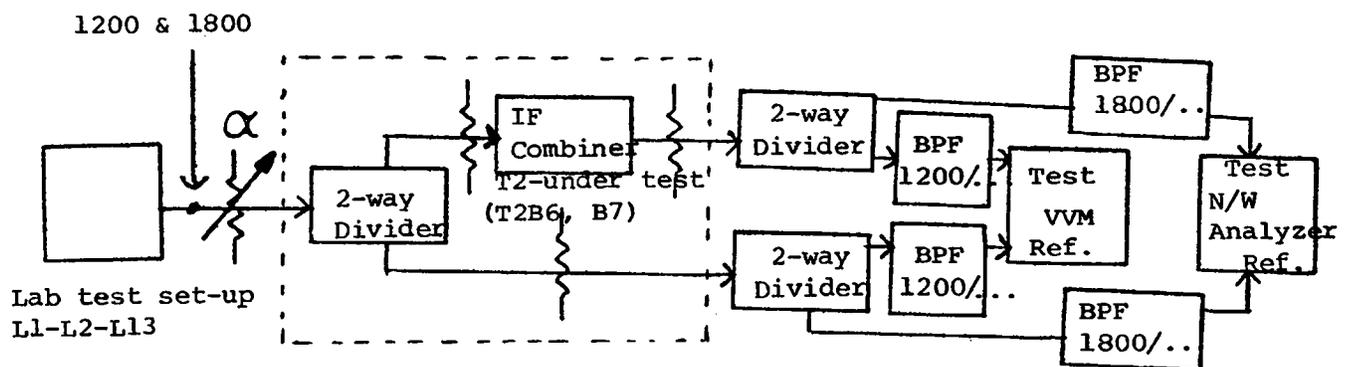
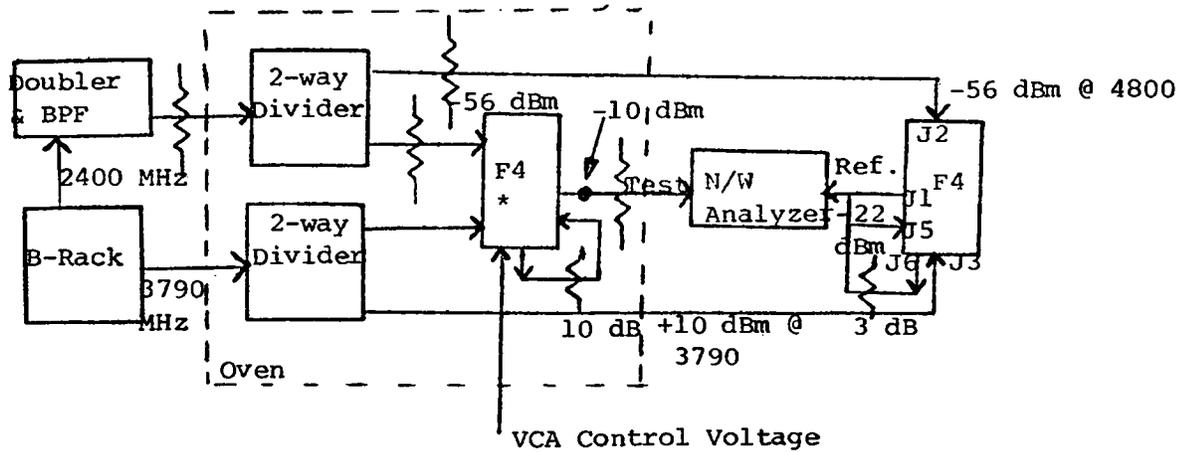


FIGURE 12: SET UP TO MEASURE PHASE STABILITY OF T2 MODULE



*Unit under test, has ALC loop open - VCA control voltage adjusted to provide 15 dB attenuation (nominal value). Block diagram of proposed freq. converter (F4) is shown below.

FIGURE 13A: SET UP TO MEASURE PHASE STABILITY OF F4 MODULE

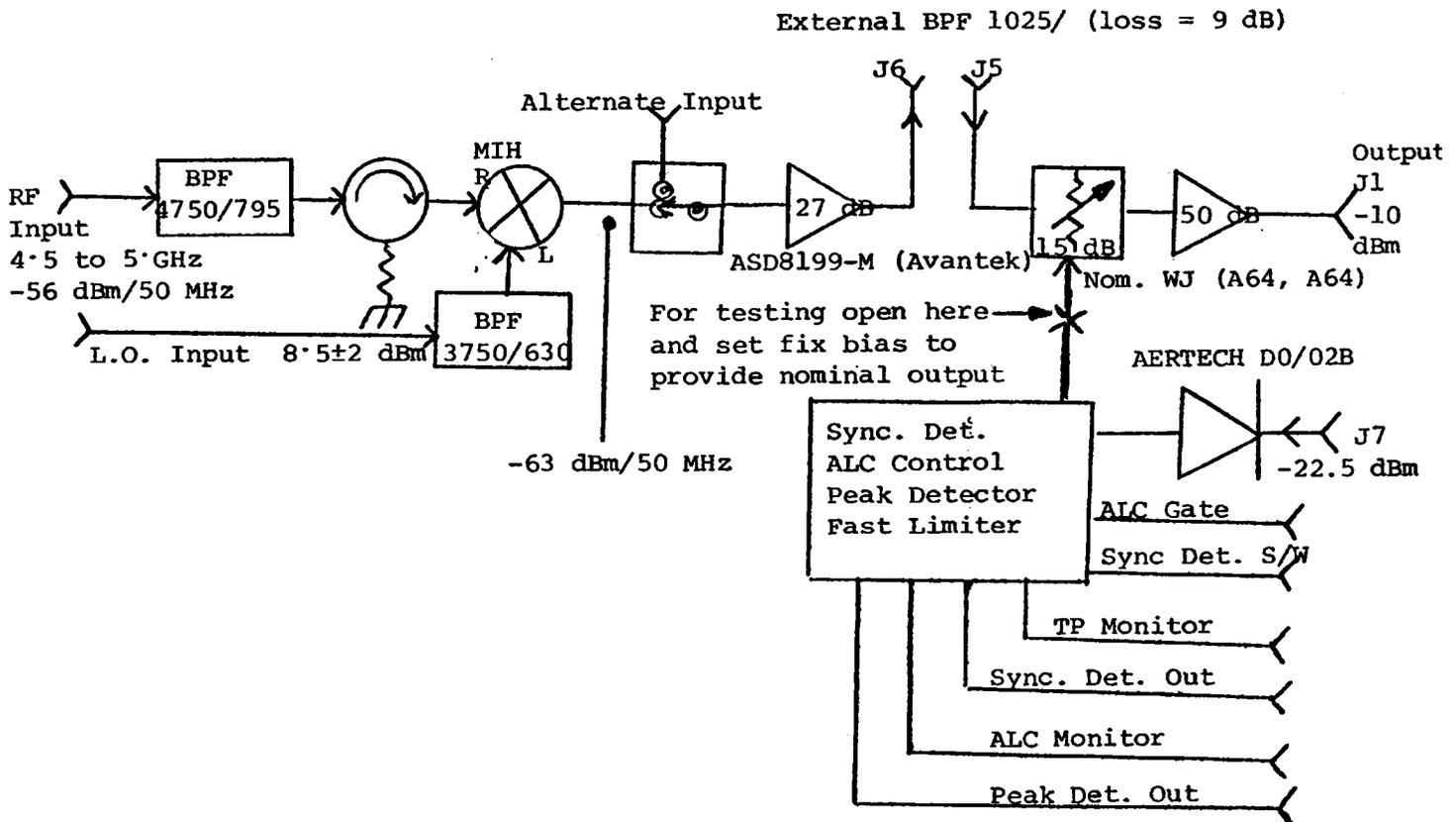


FIGURE 13B: BLOCK DIAGRAM OF PROPOSED F4, USED FOR TESTING PHASE STABILITY

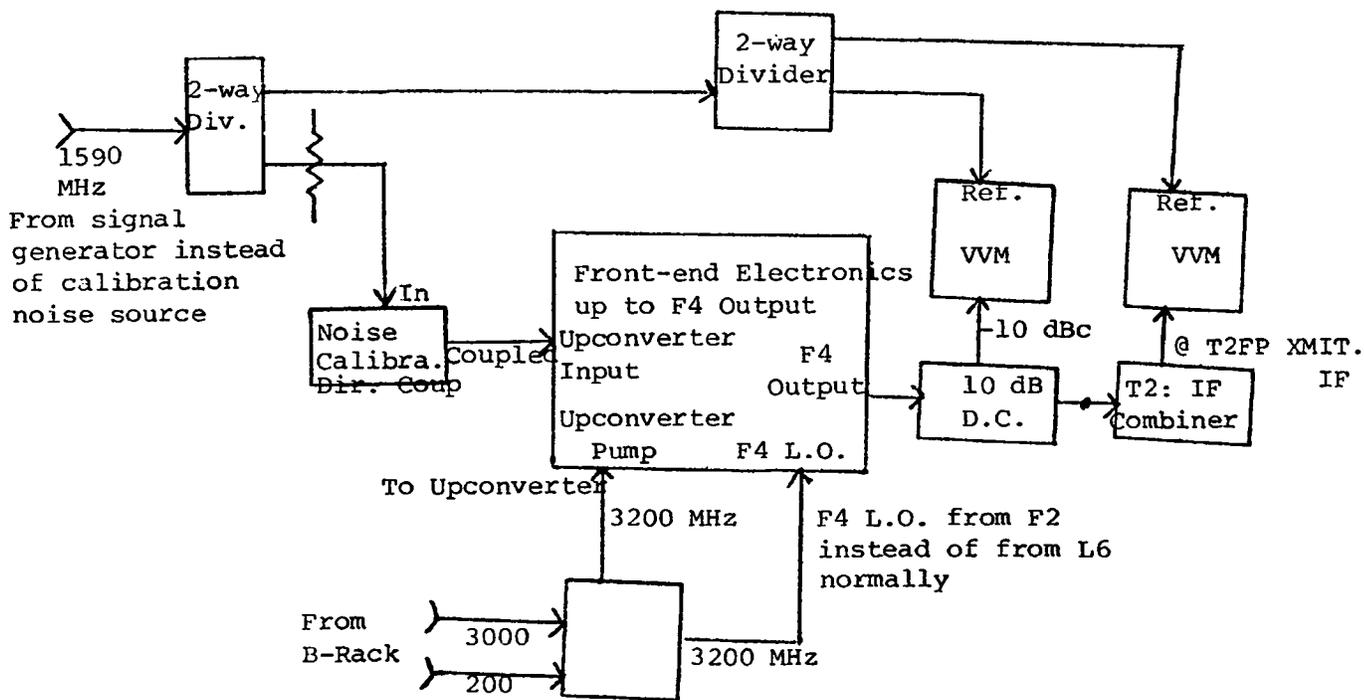


FIGURE 14: SET UP TO MEASURE FRONT-END ELECTRONICS PHASE STABILITY